

N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a		
60	0.024 at V _{GS} = 10 V	50		
00	0.028 at V _{GS} = 4.5 V	40		

FEATURES

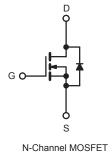
- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Logic-Level Gate Drive
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC



Ο GDS

Top View

TO-220AB



ABSOLUTE MAXIMUM RATINGS (T_{C} :	= 25 °C, unl	less otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	60	V	
Gate-Source Voltage			V _{GS}	± 20	v	
Continuous Drain Current ^f	V _{GS} at 10 V	T _C = 25 °C T _C = 100 °C	– I _D	50		
Continuous Drain Current	VGS at 10 V			36	A	
Pulsed Drain Current ^a			I _{DM}	200		
Linear Derating Factor			-	1.0	W/°C	
Linear Derating Factor (PCB Mount) ^e				0.025	VV/ C	
Single Pulse Avalanche Energy ^b			E _{AS}	400	mJ	
Maximum Power Dissipation	T _C = 25 °C		Р	150	w	
Maximum Power Dissipation (PCB Mount) ^e	T _A =	25 °C	P _D	3.7	vv	
Peak Diode Recovery dV/dt ^c			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature) ^d	for	10 s		300 ^d		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, $L = 179 \text{ }\mu\text{H}$, $R_g = 25 \Omega$, $I_{AS} = 51 \text{ A}$ (see fig. 12). c. $I_{SD} \le 51 \text{ A}$, dl/dt $\le 250 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

e. When mounted on 1" square PCB (FR-4 or G-10 material).

f. Current limited by the package, (die current = 51 A).

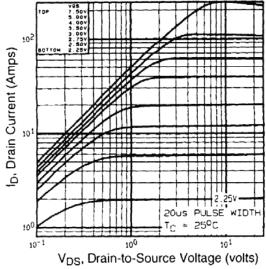
d. 1.6 mm from case.



THERMAL RESISTANCE RATI	NGS								
PARAMETER	SYMBOL	ТҮР		MAX.			UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-		62					
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-		40		°C/W			
Maximum Junction-to-Case (Drain)	R _{thJC}	- 1.0				1			
Note a. When mounted on 1" square PCB (FR-4									
SPECIFICATIONS ($T_J = 25 \text{ °C}$, u					[
PARAMETER	SYMBOL	TES		ONS	MIN.	TYP.	MAX.	UNIT	
Static	1	1			0	1			
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	= 0, I _D = 25	60 μA	60	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	$I_D = 1 \text{ mA}$	-	0.070	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 2	250 μA	1.0	-	2.5		
Gate-Source Leakage	I _{GSS}	,	$V_{\rm GS} = \pm 10^{\circ}$	V	-	-	± 100	nA	
		$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-	-	25	•	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 48 V,	$V_{GS} = 0 V,$	T _J = 150 °C	-	-	250	μA	
	_	V _{GS} = 10 V	I _D	= 21 A ^b	-	0.024	-	Ω	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 4.5 V			-	0.028	-		
Forward Transconductance	g _{fs}	V _{DS} =	= 25 V, I _D =	21A ^b	23	-	-	S	
Dynamic	0.0				I				
Input Capacitance	C _{iss}				_	190			
Output Capacitance	C _{oss}		$V_{GS} = 0 V,$ $V_{DS} = 25 V$		_	920	_	pF	
Reverse Transfer Capacitance	C _{rss}		0 MHz, see		_	170	-	р.	
Total Gate Charge	Qg				-	-	66		
Gate-Source Charge	Q _{gs}	V _{GS} = 5.0 V		A, V _{DS} = 48 V,	_	_	12	nC	
Gate-Drain Charge	Q _{gd}	VGS - 0.0 V	see fig	g. 6 and 13 ^b			43	110	
5	-						-		
Turn-On Delay Time	t _{d(on)}	$- 17$ $V_{DD} = 30 \text{ V}, \text{ I}_{D} = 51 \text{ A}, - 230$							
Rise Time	t _r						-	ns	
Turn-Off Delay Time	t _{d(off)}	ng = 110 11,	п <u>р</u> = 0.00 Ц	, 000 hg. 10			-		
Fall Time	t _f				-	110	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of		-	- nH				
Internal Source Inductance	L _S	package and center of die contact	7.5	-					
Drain-Source Body Diode Characteristi	cs								
Continuous Source-Drain Diode Current	I _S	MOSFET sym showing the			-	-	50 ^c		
Pulsed Diode Forward Current ^a	I _{SM}	integral revers p - n junction			-	-	200	A	
Body Diode Voltage	V _{SD}	T _J = 25 °C	, I _S = 51 A,	V _{GS} = 0 V ^b	-	-	2.5	V	
Body Diode Reverse Recovery Time	t _{rr}				-	130	180	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	T _J = 25 °C, I _F	= 51 A, dl/	dt = 100 A/µs ^b	-	0.84	1.3	μC	
Forward Turn-On Time	t _{on}			is negligible (turn	L			· ·	

Notes
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.
c. Current limited by the package, (Die Current = 51 A).



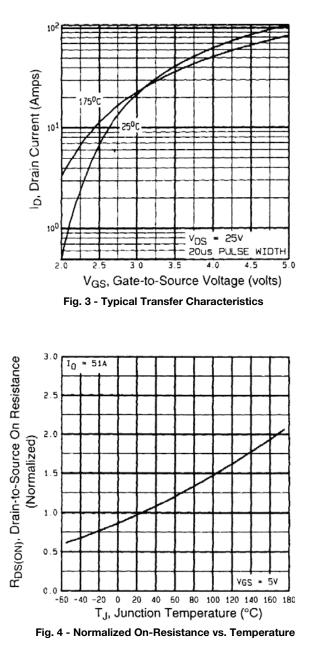


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Fig. 2 - Typical Output Characteristics, T_C = 150 °C





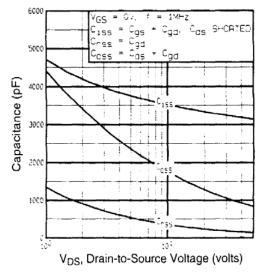


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

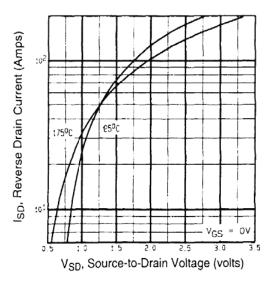
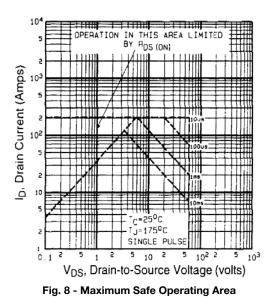


Fig. 7 - Typical Source-Drain Diode Forward Voltage



Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





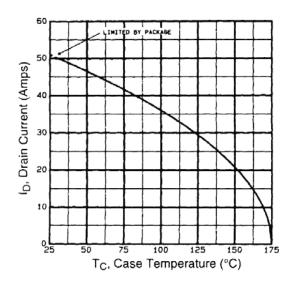


Fig. 9 - Maximum Drain Current vs. Case Temperature

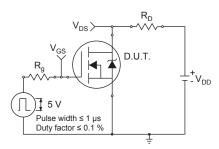


Fig. 10a - Switching Time Test Circuit

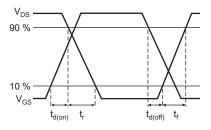
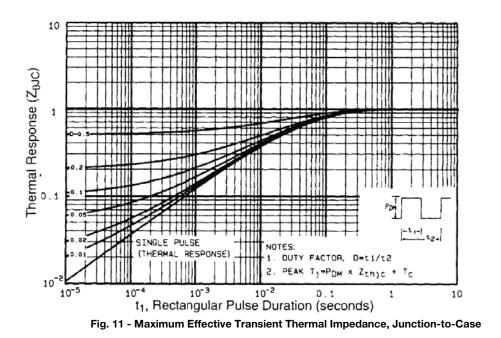


Fig. 10b - Switching Time Waveforms





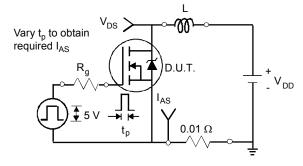


Fig. 12a - Unclamped Inductive Test Circuit

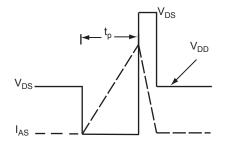


Fig. 12b - Unclamped Inductive Waveforms



Fig. 12c - Maximum Avalanche Energy vs. Drain Current

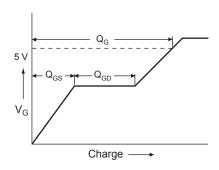


Fig. 13a - Basic Gate Charge Waveform

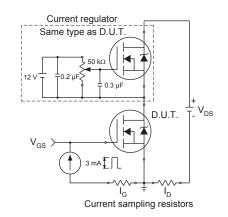
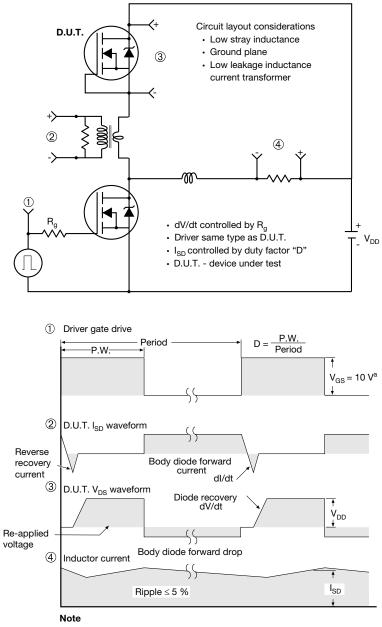


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

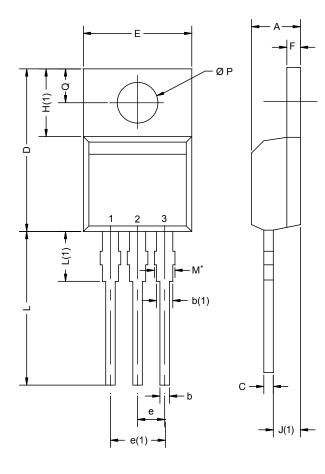


a. V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel



TO-220AB



5 9 9 9 5 5 4 1	MAX. 4.65 1.01 1.73 0.61 15.49 10.51 2.67		MIN. 0.167 0.027 0.047 0.014 0.585 0.395	MA 0.1 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0	83 40 68 24
9 5 5 4 1	1.01 1.73 0.61 15.49 10.51).027).047).014).585	0.0 0.0 0.0 0.6	40 68 24
) 5 · · · 4 · ·	1.73 0.61 15.49 10.51).047).014).585	0.0 0.0 0.6	68 24
5 ⁻ 4 ⁻	0.61 15.49 10.51	C C C).014).585	0.0	24
5 ⁻ 4 ⁻	15.49 10.51	C).585	0.6	
4 ·	10.51	C			10
		-).395	0.4	
	2.67	,		0.4	14
		C).095	0.1	05
3	5.28	C).192	0.2	08
1	1.40	C).045	0.0	55
)	6.48	C).240	0.2	55
1	2.92	C).095	0.1	15
5	14.02	C).526	0.5	52
2	3.82	C).131	0.1	50
1	3.94	C).139	0.1	55
	3.00	C).102	0.1	18
1		3.94	4 3.94 () 3.00 (3.94 0.139 3.00 0.102	3.94 0.139 0.1

Notes

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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